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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)				Application Number	10/824,425-Conf. #6507
				Filing Date	April 15, 2004
				First Named Inventor	Kazuya Yoshimura
				Art Unit	2871
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	21681-00212-US3

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
JP	AA**	US-4,971,829	11-20-1990	Canon Kabushiki Kaisha	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>4</sup>
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>2</sup> (if known)				
JP	BA**	EP-0 257 902-A1	03-02-1988	Semiconductor Energy Laboratory Co., Ltd.		
	BB**	JP-08-148654	05/1994			
	BC**	JP-08-067184	03/1994			
	BD**	JP-03-293328	12/1991			

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NON PATENT LITERATURE DOCUMENTS						
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				T <sup>2</sup>
MR	CA**	Patent Abstracts of Japan, Vol. 1997, No. 06, 30 June 1997 & JP 9 043635 A (NEC CORP.), 14 February 1997.				
	CB**	Patent Abstracts of Japan, Vol. 1997, No. 07, 31 July 1997 & JP 09 081837 A (CANON, INC.), 7 March 1997.				
	CC**	Patent Abstracts of Japan, Vol. 015, No. 084 (P-1172), 27 February 1991 & JP 02 301724 A (SEIKO EPSON CORP.), 13 December 1990.				
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MR	CE**	Patent Abstracts of Japan, Vol. 016, No. 540 (P-1450), 10 November 1992 & JP 04 204417 A (MATSUSHITA ELECTRIC IND CO LTD), 24 July 1992.				

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